Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/914,955	LINDAU, STEN
Examiner	Art Unit
Shun Lee	2878

	SEARCHED		
Class	Subclass	Date	Examiner
250	353	2/17/2005	SL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
As above v	vith PGPub	2/17/2005	SL

SEARCH NO' (INCLUDING SEARCH		)
	DATE	EXMR
EAST text "(((quantum adj well) with (sensor detector (photo adj detector))photodetector)) and ((grate grated grating grates)		
with (pitch period periodicity)))"	2/17/2005	SL
<del></del>		